

Excellent Integrated System Limited

Stocking Distributor

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Kingbright AT3228SE9ZS-RV

For any questions, you can email us directly: <u>sales@integrated-circuit.com</u>



Distributor of Kingbright: Excellent Integrated System Limited Datasheet of AT3228SE9ZS-RV - LED 635 RED-ORN 3.2X2.8MM SMD Contact us: sales@integrated-circuit.com Website: www.integrated-circuit.com

Kingbright



ATTENTION **OBSERVE PRECAUTIONS** FOR HANDLING ELECTROSTATIC DISCHARGE SENSITIVE DEVICES

Features

1.Dimensions : 3.2mm X 2.8mm X 0.8mm.

2. Higher brightness.

3.Small package with high efficiency.

4.Surface mount technology.

5.ESD protection.

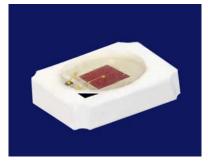
6.Moisture sensitivity level : level 2a.

7.Soldering methods: IR reflow soldering. 8.RoHS compliant.

3.2X2.8mm SMD LED WITH CERAMIC SUBSTRATE

Part Number: AT3228SE9ZS-RV

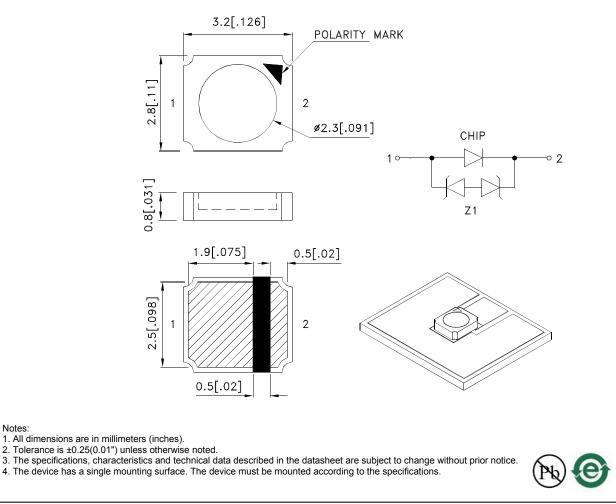
Reddish-Orange



Material as follows:

Package : Ceramics Encapsulating resin : Silicone resin Electrodes : Ag plating

Package Dimensions



SPEC NO: DSAI6844

Notes:

REV NO: V.7

DATE: APR/13/2011



3.2X2.8mm SMD LED WITH CERAMIC SUBSTRATE

Selection Guide						
Part No.	Dice	Φν (lm) [2] @ 350mA			Viewing Angle [1]	
		Code.	Min.	Max.	201/2	
AT3228SE9ZS-RV		В3	14	17		
	Daddieb Orenna (AlCalaD)	B4	17	20	120°	
	Reddish-Orange (AlGaInP)	B5	20	24		
		B6	24	29		

Notes:

1. θ 1/2 is the angle from optical centerline where the luminous intensity is 1/2 of the optical peak value.

2. Luminous intensity / luminous flux: +/-15%.

Absolute Maximum Ratings at T_A = 25°C

Parameter	Symbol	Value	Unit
DC Forward Current [1]	lF	350	mA
Peak Forward Current [2]	Іғм	500	mA
Power dissipation	Po	1.05	W
Operating Temperature	Тор	-40 To +100	°C
Storage Temperature	Tstg	-40 To +120	°C
Reverse Voltage	VR	5	V
Junction temperature[1]	TJ	120	°C
Thermal resistance [1] (Junction/ambient)	Rth j-a	95	°C/W
Thermal resistance [1] (Junction/solder point)	Rth j-s	30	°C/W

Notes:

1. Results from mounting on metal core PCB, mounted on pc board-metal core PCB is recommend.

for lowest thermal resistance.

2. 1/10 Duty Cycle, 0.1ms Pulse Width.

Electrical / Optical Characteristics at TA = 25°C

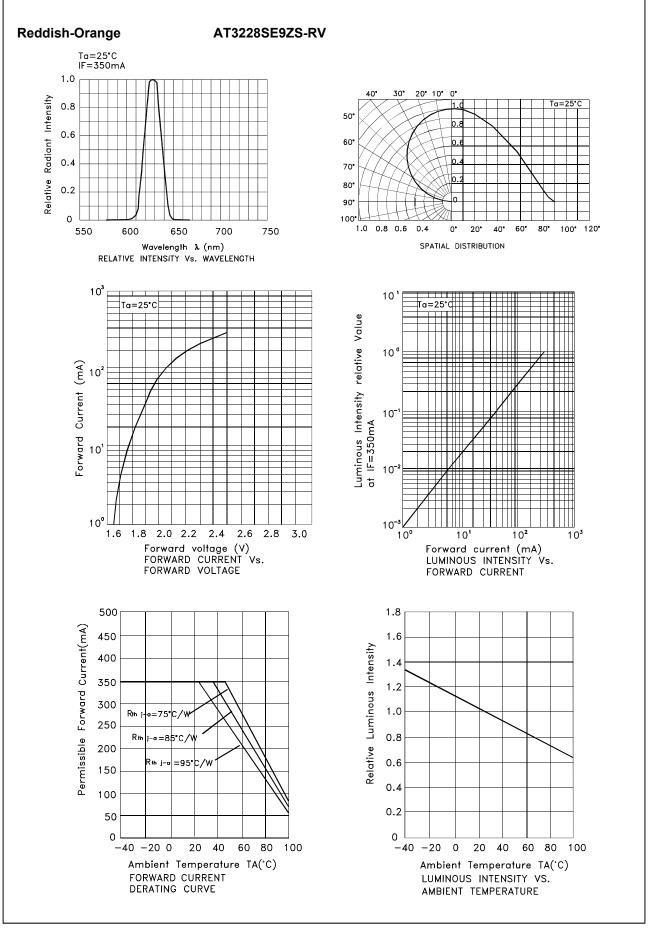
Parameter	Symbol	Value	Unit
Forward Voltage IF = 350mA [Min.]		2.0	
Forward Voltage IF = 350mA [Typ.]	VF [2]	2.5	V
Forward Voltage IF = 350mA [Max.]		3.0	
Luminous Flux IF = 350mA [Typ.]	Φν	20	lm
Allowable Reverse Current [Max.]	lr	85	mA
Wavelength at peak emission IF = 350mA [Typ.]	λpeak	635	nm
Dominant Wavelength I⊧ = 350mA [Typ.]	λ dom [1]	623	nm
Spectral bandwidth at 50% $\Phi_{\text{REL MAX}}$ IF = 350mA [Typ.]	Δλ	22	nm
Temperature coefficient of $\lambda peak$ IF = 350mA, - $10^{\circ}C \leq T \leq 100^{\circ}C$ [Typ.]	TCҳpeak	0.1	nm/°C
Temperature coefficient of λdom IF = 350mA, - $10^{\circ}C \leq T \leq 100^{\circ}C$ [Typ.]	TCλdom	0.08	nm/°C
Temperature coefficient of VF IF = 350mA, - $10^{\circ}C \le T \le 100^{\circ}C$ [Typ.]	TCv	-3.0	mV/°C

1.Wavelength : + / -1nm.

2. Forward Voltage : + / - 0.1V.



3.2X2.8mm SMD LED WITH CERAMIC SUBSTRATE

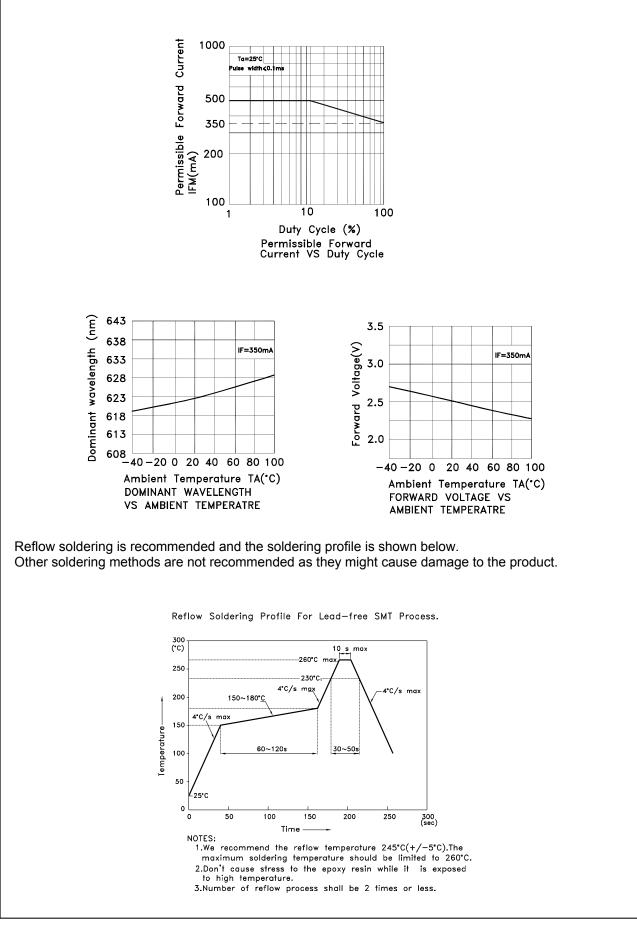


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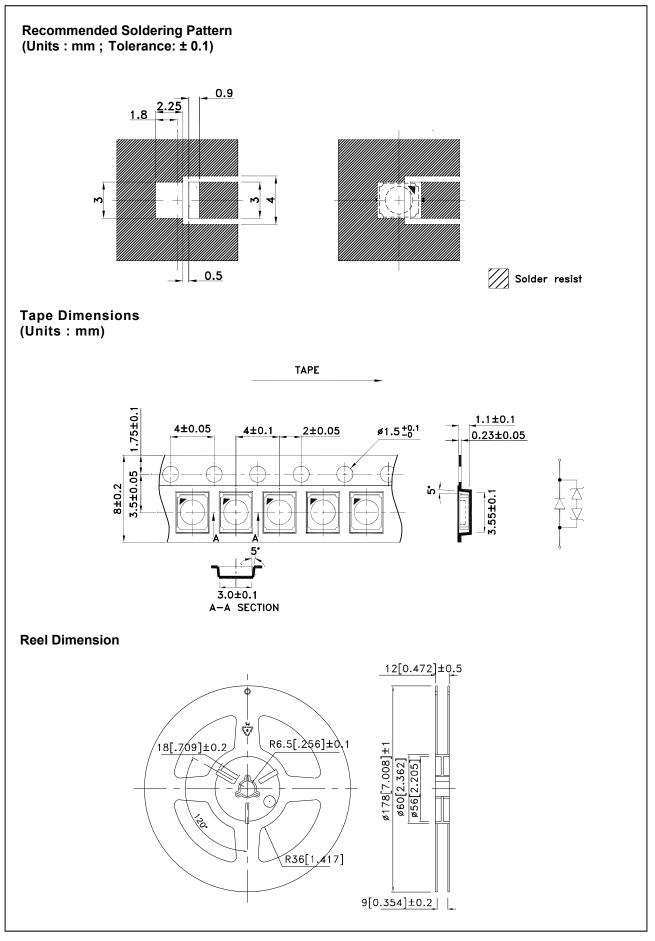
3.2X2.8mm SMD LED WITH CERAMIC SUBSTRATE



REV NO: V.7

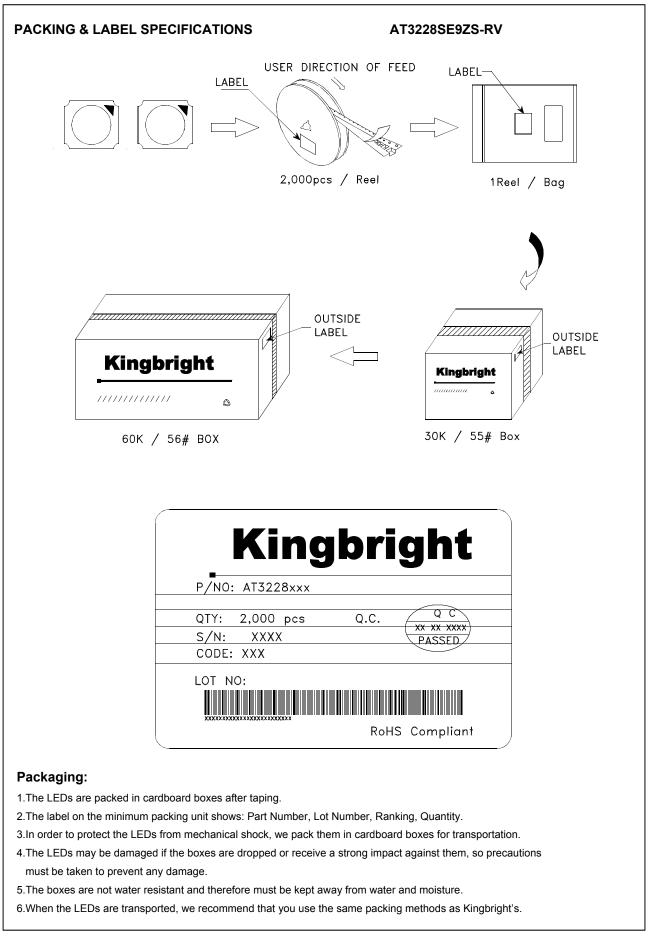


3.2X2.8mm SMD LED WITH CERAMIC SUBSTRATE





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JEDEC Moisture Sensitivity:

Loval	Eloor Life		Soak Requirements			
Level	Floor Life		Standard Accelerated Equi		ated Equivalent	
	Time	Conditions	Time (hours)	Conditions	Time (hours)	Conditions
2a	4 weeks	≤ 30 °C / 60% RH	696 ² + 5 / - 0	30 °C / 60% RH	120 + 1 / - 0	60 °C / 60% RH

Notes:

- CAUTION The "accelerated equivalent" soak requirements shall not be used until correlation of damage response, including electrical, after soak and reflow is established with the "standard" soak requirements or if the known activation energy for diffusion is 0.4 - 0.48 eV. Accelerated soak times may vary due to material properties, e.g., mold compound, encapsulant, etc. JEDEC document JESD22-A120 provides a method for determining the diffusion coefficient.
- 2. The standard soak time includes a default value of 24 hours for semiconductor manufacturer's exposure time (MET) between bake and bag and includes the maximum time allowed out of the bag at the distributor's facility.
- If the actual MET is less than 24 hours the soak time may be reduced. For soak conditions of 30 °C/60% RH the soak time is reduced by one hour For each hour the MET is less than 24 hours. For soak conditions of 60 °C/60% RH, the soak time is reduced by one hour for each five hours the MET is less than 24 hours.

If the actual MET is greater than 24 hours the soak time must be increased. If soak conditions are 30 °C/60% RH, the soak time is increased one Hour for each hour that the actual MET exceeds 24 hours. If soak conditions are 60 °C/60% RH, the soak time is increased one hour for each five Hours that the actual MET exceeds 24 hours.

3. Supplier may extend the soak times at their own risk.

ESD Protection During Production

Electric static discharge can result when static-sensitive products come in contact with the operator or other conductors.

The following procedures may decrease the possibility of ESD damage:

1. Minimize friction between the product and surroundings to avoid static buildup.

2.All production machinery and test instruments must be electrically grounded.

3.Operators must wear anti-static bracelets.

4.Wear anti-static suit when entering work areas with conductive machinery.

5.Set up ESD protection areas using grounded metal plating for component handling.

6.All workstations that handle IC and ESD-sensitive components must maintain an electrostatic potential of 150V or less.

7. Maintain a humidity level of 50% or higher in production areas.

8.Use anti-static packaging for transport and storage.

9.All anti-static equipment and procedures should be periodically inspected and evaluated for proper functionality.

Heat Generation:

1. Thermal design of the end product is of paramount importance. Please consider the heat generation of the LED when making the system design. The coefficient of temperature increase per input electric power is affected by the thermal resistance of the circuit board and density of LED placement on the board ,as well as other components. It is necessary to avoid intense heat generation and operate within the maximum ratings given in this specification.

2.Please determine the operating current with consideration of the ambient temperature local to the LED and refer to the plot of Permissible Forward current vs. Ambient temperature on CHARACTERISTICS in this specification. Please also take meas ures to remove heat from the area near the LED to improve the operational characteristics on the LED.

3. The equation $\oplus\;$ indicates correlation between Tj and Ta ,and the equation $\otimes\;$ indicates correlation between Tj and Ts $\;$

Tj =	• Ta +	Rthj-a *W		1
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Tj = Ts + Rthj-s *W 2

Tj = dice junction temperature: °C

Ta = ambient temperature:°C

Ts = solder point temperature:°C

Rthj-a = heat resistance from dice junction temperature to ambient temperature : °C/ W

Rthj-s = heat resistance from dice junction temperature to Ts measuring point : $^{\circ}C/W$

W = inputting power (IFx VF) : W

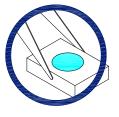


3.2X2.8mm SMD LED WITH CERAMIC SUBSTRATE

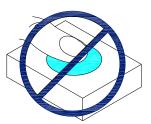
Handling Precautions

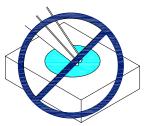
Compare to epoxy encapsulant that is hard and brittle, silicone is softer and flexible. Although its characteristic significantly reduces thermal stress, it is more susceptible to damage by external mechanical force. As a result, special handling precautions need to be observed during assembly using silicone encapsulated LED products. Failure to comply might lead to damage and premature failure of the LED.

1. Handle the component along the side surfaces by using forceps or appropriate tools.

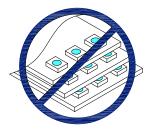


2. Do not directly touch or handle the silicone lens surface. It may damage the internal circuitry.





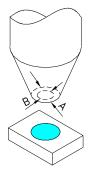
3. Do not stack together assembled PCBs containing exposed LEDs. Impact may scratch the silicone lens or damage the internal circuitry.



4.1. The outer diameter of the SMD pickup nozzle should not exceed the size of the LED to prevent air leaks. The inner diameter of the nozzle should be as large as possible.

4.2. A pliable material is suggested for the nozzle tip to avoid scratching or damaging the LED surface during pickup.

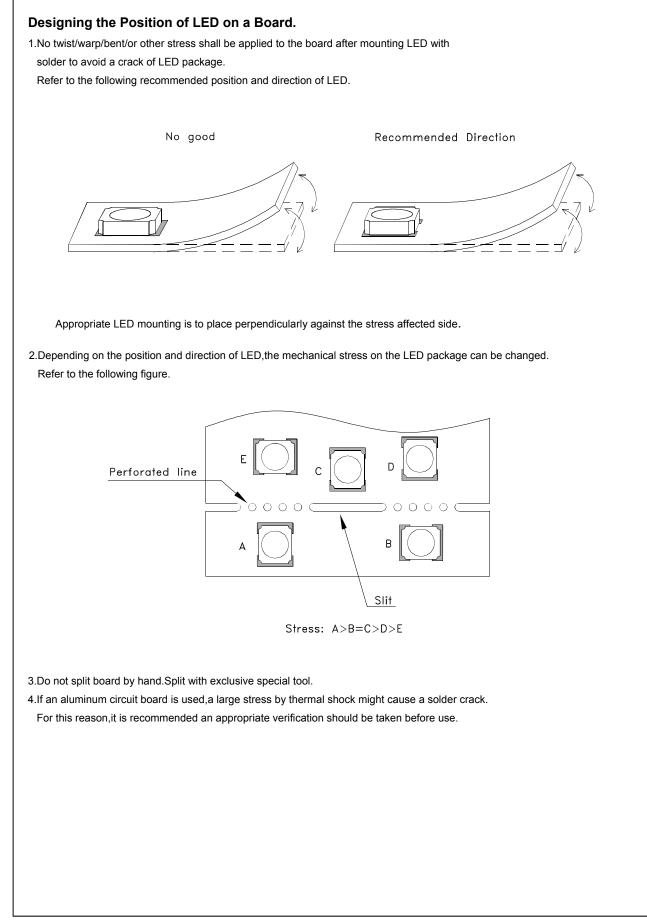
4.3. The dimensions of the component must be accurately programmed in the pick-and-place machine to insure precise pickup and avoid damage during production.



5. As silicone encapsulation is permeable to gases, some corrosive substances such as H_2S might corrode silver plating of leadframe. Special care should be taken if an LED with silicone encapsulation is to be used near such substances.



3.2X2.8mm SMD LED WITH CERAMIC SUBSTRATE





3.2X2.8mm SMD LED WITH CERAMIC SUBSTRATE

Reliability Test Items And Conditions

The reliability of products shall be satisfied with items listed below Lot Tolerance Percent Defective (LTPD): 10%

No.	Test Item	Standards	Test Condition	Test Times / Cycles	Number of Damaged
1	Continuous operating test	-	Ta =25°C +10/-5°C ,RH=55+/-20%RH IF = maximum rated current*	1,000 h	0 / 22
2	High Temp. operating test	-	Ta = 100°C(+/-10°C) IF = maximum rated current*	1,000 h	0 / 22
3	Low Temp. operating test	-	Ta = -40°C+3/-5°C IF = maximum rated current*	1,000 h	0 / 22
4	High temp. storage test	JEITA ED- 4701/200 201	Ta = 100°C(+/-10°C) Ta = maximum rated storage temperature	1,000 h	0 / 22
5	Low temp. storage test	JEITA ED- 4701/200 202	Ta = -40°C+3/-5°C	1,000 h	0 / 22
6	High temp. & humidity storage test	JEITA ED- 4701/100 103	Ta = 60°C+5/-3°C, RH = 90+5/-10%RH	1,000 h	0 / 22
7	High temp. & humidity operating test	-	Ta = 60°C+5/-3°C, RH = 90%+5/-10%RH IF = maximum rated current*	500h	0 / 22
8	Resistance to Soldering Heat (Reflow Soldering)	JEITA ED- 4701/300 301	Tsld=260°C,10sec	2 times	0 / 22
9	Solderability (Reflow Soldering)	JEITA ED- 4701/300 303	Tsld=245°C+/-5°C,5+/-1sec	1 time over 95%	0 / 22
10	Temperature Cycle operating test	-	-40°C(30min) ~25°C(5min)~-100°C (30min) ~25°C(5min) IF = derated current at 100°C	10cycles	0 / 22
11	Temperature Cycle	JEITA ED- 4701/100 105	-40°C(30min) ~25°C(5min)~-100°C (30min) ~25°C(5min)	100cycles	0 / 22
12	Thermal shock test	MIL-STD- 202G	Ta = -40°C(15min) ~100°C(15min)	500 cycles	0 / 22
13	Electric Static Discharge (ESD)	JEITA ED- 4701/300 304	C = 100pF , R= 1.5KΩ V = 250V	3 times Negative/ Positive	0 / 22
14	Vibration test	JEITA ED- 4701/400 403	100~2000~100HZ Sweep 4min. 200m/s² 3directions,4cycles	48min.	0 / 22

* : Refer to forward current vs. derating curve diagram.

Criteria For Judging Damage

Item	Symbol	Test Conditions	t Conditions	
liem	Symbol		Min.	Max.
Forward Voltage	VF	IF = 350mA	-	Initial Level x 1.1
Luminous Flux	Φν	IF = 350mA	Initial Level x 0.7	-

* : The test is performed after the board is cooled down to the room temperature.